SN5410, SN54LS10, SN54S10, SN7410, SN74LS10, SN74S10 TRIPLE 3-INPUT POSITIVE-NAND GATES

DECEMBER 1983 - REVISED MARCH 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

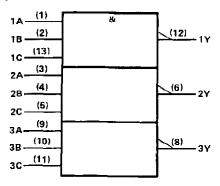
These devices contain three independent 3-input NAND gates.

The SN5410, SN54LS10, and SN54S10 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN7410, SN74LS10, and SN74S10 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each gate)

- 11	VPUT	s	OUTPUT
А	В	С	Y
Н	Н	н	L
L	X	X	н
Х	L	×	н
х	X	L	H

logic symbol†



[†]This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D. J. and N packages.

positive logic

$$Y = \overline{A \cdot B \cdot C}$$
 or $Y = \overline{A} + \overline{B} + \overline{C}$

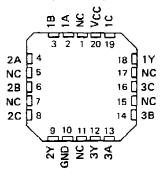
SN5410 . . . J PACKAGE
SN54LS10, SN54S10 . . . J OR W PACKAGE
SN7410 . . . N PACKAGE
SN74LS10, SN74S10 . . . D OR N PACKAGE
(TOP VIEW)

		•
1A 🗆	1	U14 Vcc
1B 🗆	2	13 Д 1С
2A 🗆	3	12 1Y
28 🗆	4	11∏ 3C
2C 🗆	5	10 □ 3B
2Y 🗀	6	9 ∐ 3A
GND 🛚	7	в Д З Ү

SN5410 . . . W PACKAGE

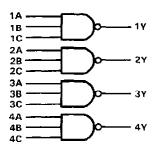
	1	101	. A1	Evi	,	
1A		1	U	14	Ь	1C
1B	ロ	2		13		3Y
1Y	q	3		12		3C
Vcc		4		11		GNE
2Y	◁	5		10		3B
2A	d	6		9		ЗА
2B	d	7		8		2C

SN54LS10, SN54S10...FK PACKAGE (TOP VIEW)

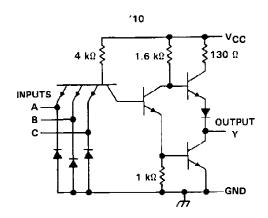


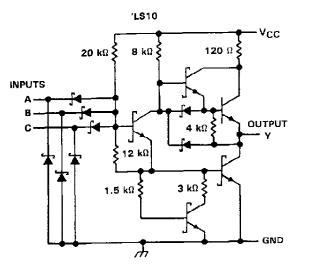
NC - No internal connection

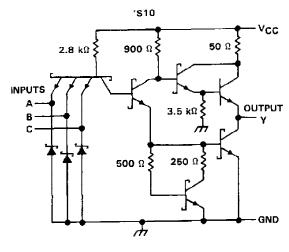
logic diagram (positive logic)



schematics (each gate)







Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)		٧
Input voltage: '10, 'S10	, 5.5	V
(LS10	<i></i> 7	٧
Operating free-air temperature range: SN54'	55°C to 125°	٥C
SN74'	. 0°C to 70°	°C
Storage temperature range		

NOTE 1: Voltage values are with respect to network ground terminal.



recommended operating conditions

			SN5410			SN7410)	דומט
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			8.0	V
ЮН	High-level output current			- 0.4			- 0.4	mΑ
loL	Low-level output current			16			16	mΑ
TA	Operating free-air temperature	- 55		125	0		70	°c

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITIONS T			SN5410			SN7410			
PARAMETER			MIN	TYP‡	MAX	MIN	TYP\$	MAX	UNIT	
VIK	V _{CC} = MIN, I ₁ = - 12	mA			- 1.5			- 1.5	٧	
Voн	V _{CC} = MIN, V _{IL} = 0.8	3 V, I _{OH} = - 0.4 mA	2.4	3.4		2.4	3.4	_	٧	
VoL	V _{CC} = MIN, V _{IH} = 2 \	V, I _{OL} = 16 mA		0.2	0.4		0.2	0.4	٧	
l _l	V _{CC} = MAX, V _I = 5.5 \	v			1			1	mA	
¹ ІН	V _{CC} = MAX, V ₁ = 2.4 V	v			40		10	40	μА	
ارر	V _{CC} = MAX, V _I = 0.4 V	v			- 1.6			- 1.6	mΑ	
¹os§	V _{CC} = MAX		- 20		- 55	- 18		- 55	mA	
Іссн	V _{CC} = MAX, V _I = 0 V			3	6		3	6	mΑ	
ICCL	V _{CC} = MAX, V _I = 4.5 \	v		9	16.5		9	1 6. 5	mΑ	

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. ‡ All typical values are at V_{CC} = 5 V, T_A = 25°C. **§** Not more than one output should be shorted at a time.

switching characteristics, VCC = 5 V, TA = 25°C (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	DITIONS	MIN	TYP	MAX	ŲNIT
tPLH						11	22	กร
^t PHL	A, B or C	Y	R _L = 400 Ω,	C _L = 15 pF		7	15	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

SN54LS10, SN74LS10 TRIPLE 3-INPUT POSITIVE-NAND GATES

recommended operating conditions

		SN54LS	310	SN74LS10			
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC Supply voltage	4.5	5	5.5	4.75	5	5.25	٧
VIH High-level input voltage	2			2			٧
VIL Low-level input voltage			0.7			8.0	٧
IOH High-level output current			- 0.4			- 0.4	mΑ
IOL Low-level output current			4			8	mΑ
TA Operating free-air temperature	- 55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITION			SN54LS	10		SN74LS	310	UNIT
PARAMETER	TEST CORDITIONS (MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNII
VIK	VCC = MIN, II = - 18 mA	·			- 1.5			- 1.5	V
∨он	VCC = MIN, VIL = MAX, IC)H = - 0.4 mA	2.5	3.4		2.7	3.4		V
	VCC = MIN, VIH = 2 V, IC)L = 4 mA		0.25	0.4			0.4	,
VOL	VCC = MIN. VIH = 2 V, IC)L = 8 mA				·	0.25	0.5	1
lį	V _{CC} = MAX, V ₁ = 7 V				0.1		-	0.1	mΑ
^Т ІН	V _{CC} = MAX, V _I = 2.7 V				20			20	μА
ħΕ	V _{CC} = MAX, V _I = 0.4 V	······································			- 0.4			- 0.4	mΑ
los§	V _{CC} = MAX		- 20		- 100	- 20		- 100	mA
1ссн	V _{CC} = MAX, V _I = 0 V			0.6	1.2		0.6	1.2	mΑ
ICCL	V _{CC} = MAX, V ₁ = 4.5 V			1.8	3.3		1.8	3.3	mΑ

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, VCC = 5 V, TA = 25°C (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
₹PLH	A, B or C	V	RL=2kΩ,	C. = 15 oC		9	15	ns
tPHL	7,50.0	•	RL = 2 kΩ, CL = 15 ρF			10	15	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_{\Delta} = 25^{\circ}\text{C}$. § Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

recommended operating conditions

			SN!	4 S1	0		SN748	10	l
		MIN	N	DM	MAX	MIN	NOM	МАХ	UNIT
VCC	Supply voltage	4.5		5	5.5	4.75	5	5.25	V
VIН	High-level input voltage	- 2				2			٧
VIL	Low-level input voltage				8.0			0.8	٧
ЮН	High-level output current				_ 1			– 1	πА
IOT	Low-level output current				20			20	mΑ
TA	Operating free-air temperature	– 55			125	0		70	°c

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS †	SN54S10	SN74S10	UNIT
PARAMETER	TEST CONDITIONS I	MIN TYP‡ MAX	MIN TYP# MAX	UNIT
VIK	V _{CC} = MIN, I _I = -18 mA	-1.2	-1.2	٧
V _{OH}	V _{CC} = MIN, V _{IL} = 0.8 V, I _{OH} = -1 mA	2.5 3.4	2.7 3.4	٧
VOL	V _{CC} = MIN, V _{IH} = 2 V, l _{OL} = 20 mA	0.5	0.5	٧
Ιį	V _{CC} = MAX, V _I = 5,5 V	1	t n	mΑ
I _{IH}	V _{CC} = MAX, V _I = 2.7 V	50	50 μ	μА
ηL	V _{CC} = MAX. V _I = 0.5 V	-2	_2 n	mΑ
10S§	V _{CC} = MAX	-40 -100	—40 —100 п	mΑ
Іссн	V _{CC} = MAX, V _I = 0 V	7,5 12	7.5 12 n	mΑ
ICCL	V _{CC} = MAX, V _I = 4.5 V	15 27	15 27 n	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPU T)	TEST CONDITIONS	MIN TYP	MAX	UNIT
tpLH	A, B or C	Y	R _L - 280 Ω, C _I = 15 pF	3	4.5	ns
^t PHL			R _L = 280 Ω, C _L = 15 pF	3	5	ns
tPLH			G - 50 - 5	4.5		rts
tPHL_			$R_L = 280 \Omega$, $C_L = 50 pF$	5		ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C. § Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.

Copyright © 1996, Texas Instruments Incorporated

IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1998, Texas Instruments Incorporated